

**Search Notes**

Application/Control No.

10/632,825

Examiner

Evan Pert

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2826

**SEARCHED**

Class	Subclass	Date	Examiner
438	396	2/18/2005	EP
438	591	2/18/2005	EP
438	778	2/18/2005	EP
438	780	2/18/2005	EP
438	781	2/18/2005	EP
438	785	2/18/2005	EP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST BRS (printouts of strategy in record)	2/18/2005	EP
IEEE Explore (printout of strategy in record)	2/18/2005	EP
google.com search "TEMAH hafnium"	2/18/05	EP